

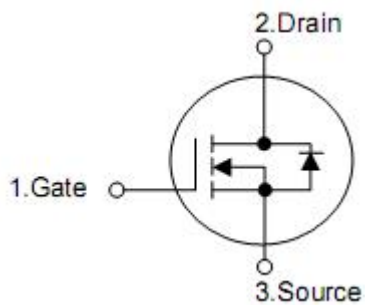
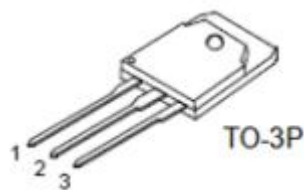
1. Features

- Proprietary New Planar Technology
- $R_{DS(ON),typ.}=20m\Omega@V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

2. Features

- DC-DC Converters
- DC-AC Inverters for UPS
- SMPS and Motor controls

3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source

4. Ordering Information

Part Number	Package	Brand
KNH3320A	TO-3P	KIA

5. Absolute maximum ratings

TC=25 °C unless otherwise specified

Parameter	Symbol	Ratings	Unit
Drain-to-Source Voltage ^[1]	V _{DSS}	200	V
Gate-to-Source Voltage	V _{GSS}	±20	
Continuous Drain Current	I _D	90	A
Continuous Drain Current @ T _c =100 °C		70	
Pulsed Drain Current at V _{GS} =10V ^[2]	I _{DM}	360	
Single Pulse Avalanche Energy	E _{AS}	2500	mJ
Peak Diode Recovery dv/dt ^[3]	dv/dt	5.0	V/ns
Power Dissipation	P _D	575	W
Derating Factor above 25 °C		3.8	W/ °C
Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10 seconds, Package Body for 10 seconds	T _L T _{PAK}	300 260	°C
Operating and Storage Temperature Range	T _J & T _{STG}	-55 to 150	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

6. Thermal characteristics

Parameter	Symbol	Ratings	Units
Thermal resistance, junction-ambient	R _{θJA}	50	°C/W
Thermal resistance, Junction-case	R _{θJC}	0.26	

7. Electrical characteristics

(T_J=25°C, unless otherwise notes)

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Off characteristics						
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	200	-	-	V
Drain-to-source Leakage Current	I _{DSS}	V _{DS} =200V, V _{GS} =0V	-	-	10	μA
		V _{DS} =160V, V _{GS} =0V T _J =125°C,	-	-	100	μA
Gate-body leakage current	I _{GSS}	V _{GS} =20V, V _{DS} =0V	-	-	+100	nA
		V _{GS} =-20V, V _{DS} =0V	-	-	-100	nA
On characteristics						
Static drain-source on-resistance ^[4]	R _{DS(on)}	V _{DS} =10V, I _D =45A	-	20	25	mΩ
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.0	-	4.0	V
Forward Transconductance ^[4]	g _{fs}	V _{DS} =15V, I _D =56A	-	62	-	S
Dynamic characteristics						
Input capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1MHz	-	6350	-	pF
Output capacitance	C _{oss}		-	1200	-	pF
Reverse transfer capacitance	C _{rss}		-	800	-	pF
Total gate charge						
Turn-on delay time	t _{d(on)}	V _{DD} =100V, I _D =56A, V _{GS} =10V, R _G =1.2Ω	-	18	-	ns
Rise time	t _r		-	120	-	ns
Turn-off delay time	t _{d(off)}		-	68	-	ns
Fall time	t _f		-	100	-	ns
Total gate charge	Q _g	V _{DD} =100V, I _D =56A, V _{GS} =0 to 10V	-	200	-	nC
Gate-source charge	Q _{gs}		-	31	-	nC
Gate-drain charge	Q _{gd}		-	88	-	nC
Drain-source diode characteristics						
Drain-source diode forward voltage	V _{SD}	V _{GS} =0V, I _S =30A	-	-	1.5	V
Continuous drain-source current ^[4]	I _{SD}	Integral pn-diode In MOSFET	-	-	90	A
Pulsed drain-source current ^[4]	I _{SM}		-	-	360	A
Reverse recovery time	t _{rr}	V _{GS} =0V, I _F =56A DI _F /dt=100A/μs	-	390	-	ns
Reverse recovery charge	Q _{rr}		-	2.5	-	μC

Note: 1. T_J=+25°C to +150°C

2. Repetitive rating; pulse width limited by maximum junction temperature.

3. I_{SD}= 20A di/dt < 100 A/μs, V_{DD} < BVDSS, T_J=+150 °C.

4. Pulse width ≤ 380μs; duty cycle ≤ 2%.

8. Typical Characteristics

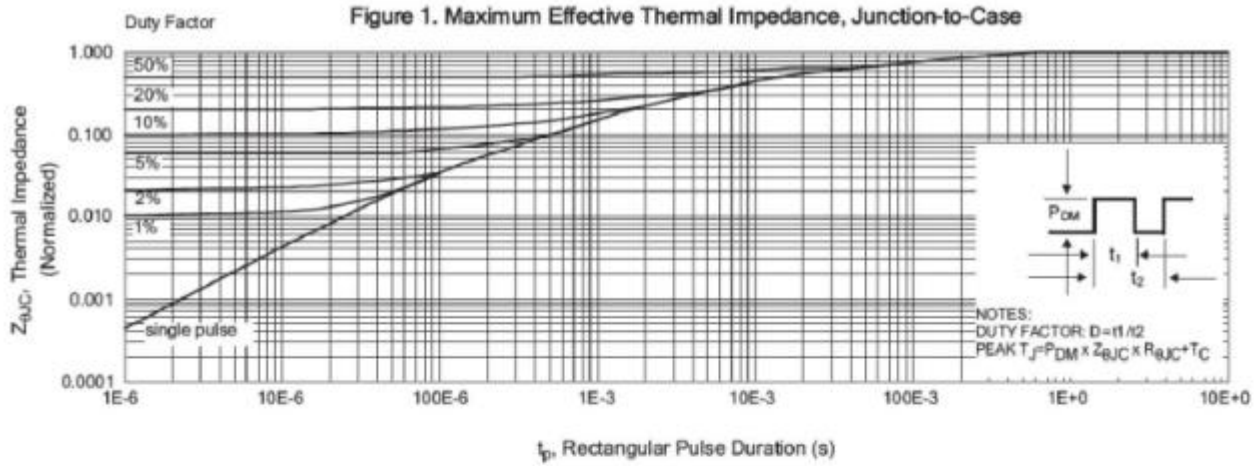


Figure 2 . Max. Power Dissipation vs Case Temperature

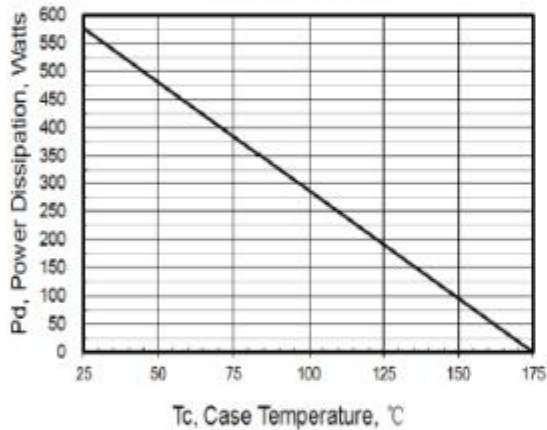


Figure 3 .Maximum Continuous Drain Current vs Tc

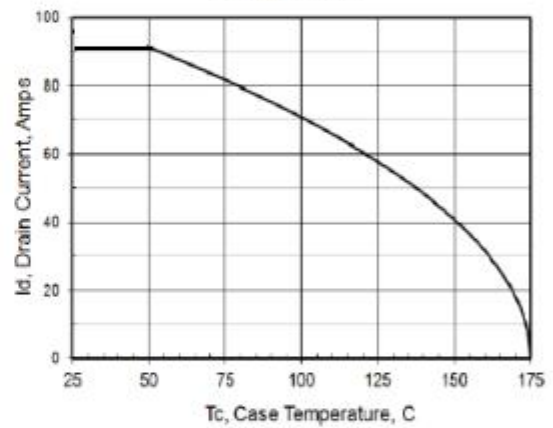


Figure 4. Typical Output Characteristics

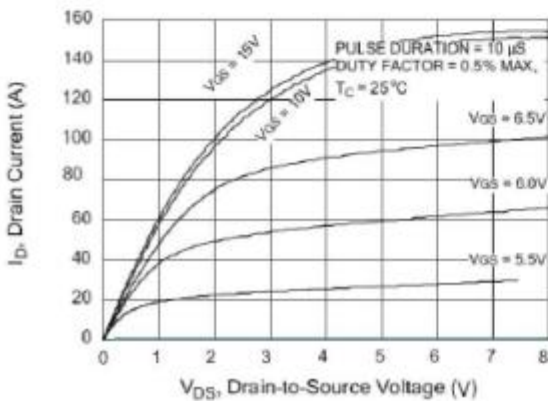


Figure5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current

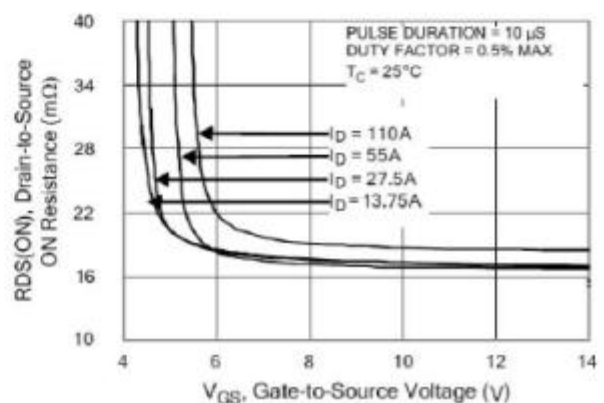


Figure 6. Peak Current Capability

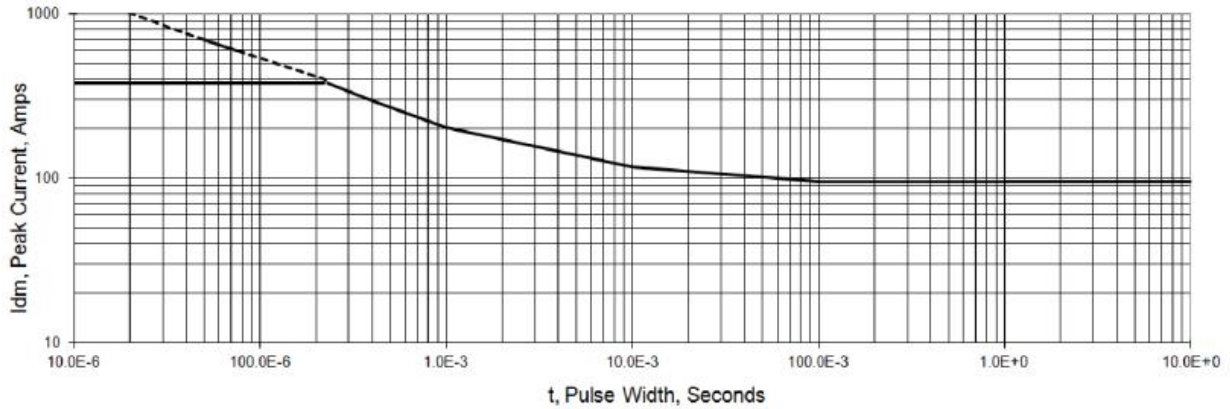


Figure 7. Typical Transfer Characteristics

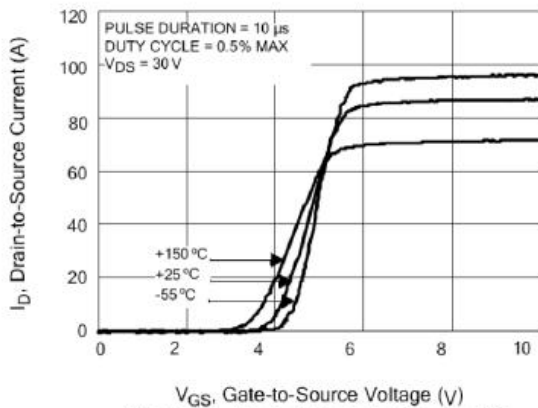


Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current

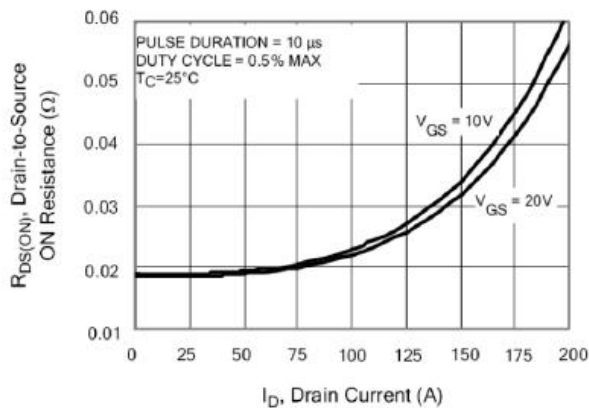


Figure 8. Unclamped Inductive Switching Capability

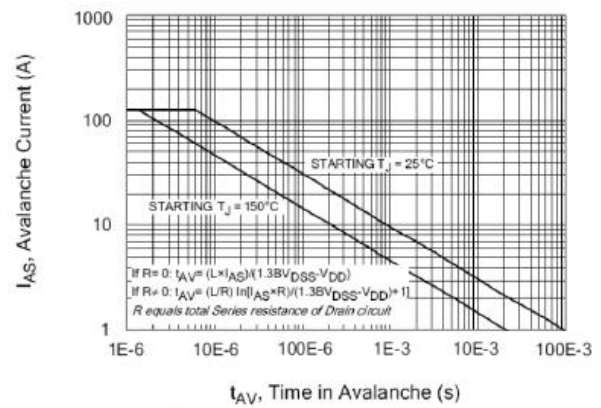


Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature

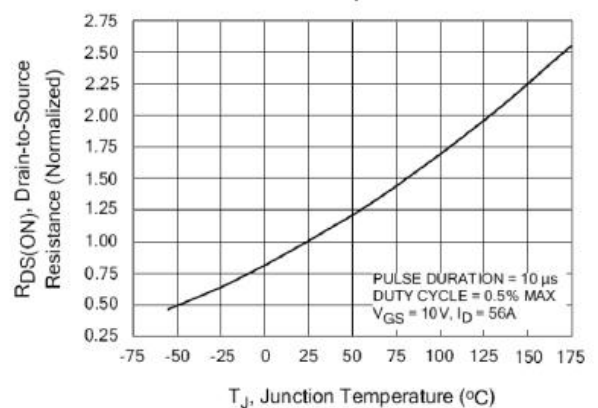


Figure 11. Typical Breakdown Voltage vs Junction Temperature

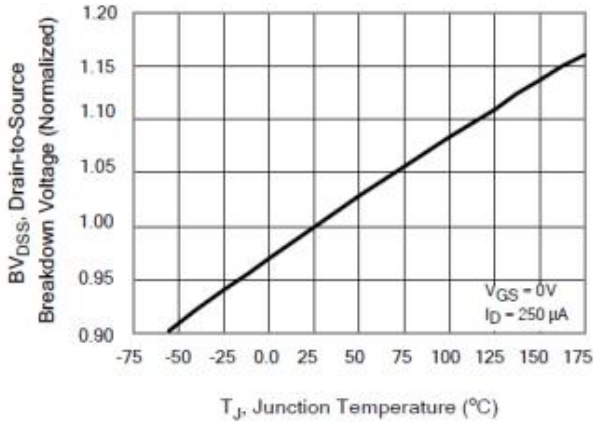


Figure 12. Typical Threshold Voltage vs Junction Temperature

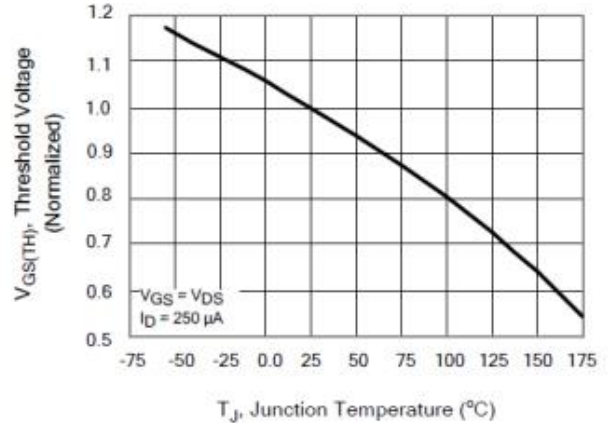


Figure 13. Maximum Safe Operating Area

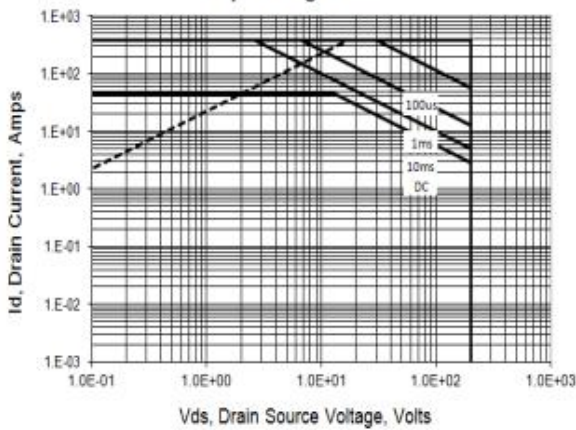


Figure 14. Capacitance vs Vds

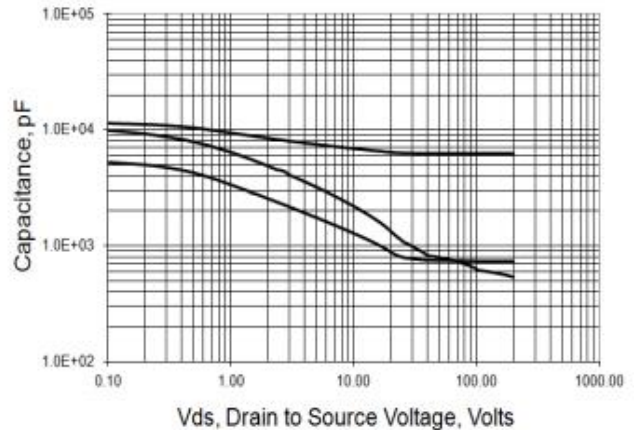


Figure 15. Typical Gate Charge

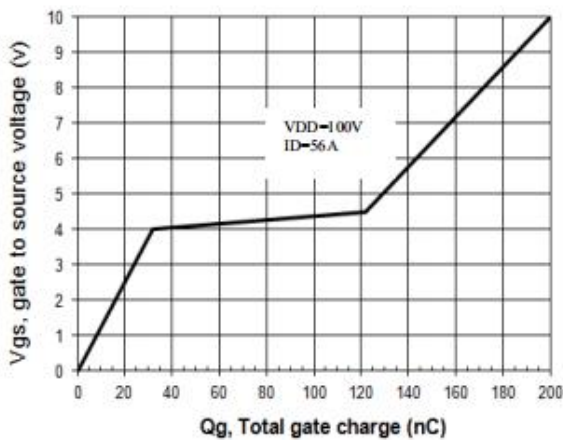


Figure 16. Typical Body Diode Transfer Characteristics

